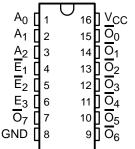
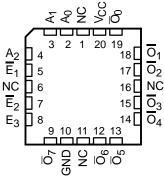
- **Function, Pinout, and Drive Compatible** With FCT and F Logic
- Reduced V<sub>OH</sub> (Typically = 3.3 V) Versions of **Equivalent FCT Functions**
- **Edge-Rate Control Circuitry for Significantly Improved Noise Characteristics**
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- **Matched Rise and Fall Times**
- Fully Compatible With TTL Input and **Output Logic Levels**
- **Dual 1-of-8 Decoder With Enables**
- **ESD Protection Exceeds JESD 22** 
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)
- CY54FCT138T
  - 32-mA Output Sink Current
  - 12-mA Output Source Current
- CY74FCT138T
  - 64-mA Output Sink Current
  - 32-mA Output Source Current

#### CY54FCT138T . . . D PACKAGE CY74FCT138T...Q OR SO PACKAGE (TOP VIEW)



CY54FCT138T...L PACKAGE (TOP VIEW)



NC - No internal connection

## description

The 'FCT138T devices are 1-of-8 decoders. These devices accept three binary weighted inputs (A<sub>0</sub>, A<sub>1</sub>, A<sub>2</sub>) and, when enabled, provide eight mutually exclusive active-low outputs  $(\overline{O}_0 - \overline{O}_7)$ . The 'FCT138T devices feature three enable inputs: two active low  $(\overline{E}_1, \overline{E}_2)$  and one active high  $(E_3)$ .

All outputs are high unless  $\overline{E}_1$  and  $\overline{E}_2$  are low and  $E_3$  is high. This multiple-enable function allows easy parallel expansion of the device to a 1-of-32 (five lines to 32 lines) decoder with just four 'FCT138T devices and one inverter.

These devices are fully specified for partial-power-down applications using Ioff. The Ioff circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

#### **PIN DESCRIPTION**

NAME	DESCRIPTION
Α	Address inputs
$\overline{E}_1, \overline{E}_2$	Enable inputs (active low)
E <sub>3</sub>	Enable input (active high)
0	Outputs



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



#### **ORDERING INFORMATION**

TA	PACI	KAGE <sup>†</sup>	SPEED (ns)	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
	QSOP - Q	Tape and reel	5	CY74FCT138CTQCT	FT138-3	
	SOIC - SO	Tube	5	CY74FCT138CTSOC	FCT138C	
-40°C to 85°C	3010 - 30	Tape and reel	5	CY74FCT138CTSOCT	FC1138C	
	QSOP - Q	Tape and reel	5.8	CY74FCT138ATQCT	FT138-1	
	SOIC - SO	Tube	5.8	CY74FCT138ATSOC	FCT138A	
	3010 - 30	Tape and reel	5.8	CY74FCT138ATSOCT	FCT 130A	
	QSOP - Q	Tape and reel	9	CY74FCT138TQCT	FT138	
	LCC – L	Tube	6	CY54FCT138CTLMB		
–55°C to 125°C	LCC – L	Tube	12	CY54FCT138TLMB		
	CDIP – D	Tube	12	CY54FCT138TDMB		

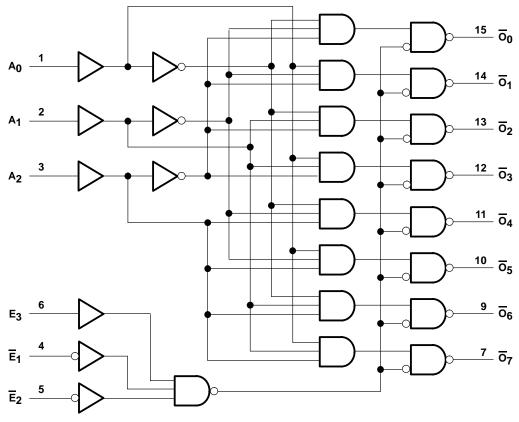
<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

#### **FUNCTION TABLE**

		INP	UTS			OUTPUTS							
E <sub>1</sub>	E <sub>2</sub>	E <sub>3</sub>	Α <sub>0</sub>	A <sub>1</sub>	A <sub>2</sub>	Ō <sub>0</sub>	<u>0</u> 1	Ō <sub>2</sub>	O <sub>3</sub>	04	<del>0</del> 5	<u>0</u> 6	07
Н	Х	Χ	Х	Χ	Х	Н	Н	Н	Н	Н	Н	Н	Н
X	Н	Χ	Χ	Χ	X	Н	Н	Н	Н	Н	Н	Н	Н
Х	X	L	Χ	Χ	X	Н	Н	Н	Н	Н	Н	Н	Н
L	L	Н	L	L	L	L	Н	Н	Н	Н	Н	Н	Н
L	L	Н	Н	L	L	Н	L	Н	Н	Н	Н	Н	Н
L	L	Н	L	Н	L	Н	Н	L	Н	Н	Н	Н	Н
L	L	Н	Н	Н	L	Н	Н	Н	L	Н	Н	Н	Н
L	L	Н	L	L	Н	Н	Н	Н	Н	L	Н	Н	Н
L	L	Н	Н	L	Н	Н	Н	Н	Н	Н	L	Н	Н
L	L	Н	L	Н	Н	Н	Н	Н	Н	Н	Н	L	Н
L	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L

H = High logic level, L = Low logic level, X = Don't care

## logic diagram (positive logic)



Pin numbers shown are for the D, Q, and SO packages.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range to ground potential	0.5 V to 7 V
DC input voltage range	–0.5 V to 7 V
DC output voltage range	–0.5 V to 7 V
DC output current (maximum sink current/pin)	120 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 1): Q package	90°C/W
SO package	57°C/W
Ambient temperature range with power applied, T <sub>A</sub>	–65°C to 135°C
Storage temperature range, T <sub>stg</sub>	−65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.



SCCS013B - MAY 1994 - REVISED OCTOBER 2001

## recommended operating conditions (see Note 2)

		CY54FCT138T			CY7	8T	UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			8.0			0.8	V
ЮН	High-level output current			-12			-32	mA
lOL	Low-level output current			32			64	mA
TA	Operating free-air temperature	-55		125	-40	•	85	°C

NOTE 2: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation.

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST COMPLTIONS	C,	Y54FCT13	88T	CY	74FCT13	8T	UNIT	
PARAMETER	TEST CONDITIONS	MIN	TYP <sup>†</sup>	MAX	MIN	TYP <sup>†</sup>	MAX	UNII	
Vara	$V_{CC} = 4.5 \text{ V}, \qquad I_{IN} = -18 \text{ mA}$		-0.7	-1.2				V	
VIK	$V_{CC} = 4.75 \text{ V}, \qquad I_{IN} = -18 \text{ mA}$					-0.7	-1.2	V	
	$V_{CC} = 4.5 \text{ V}, \qquad I_{OH} = -12 \text{ mA}$	2.4	3.3						
Vон	V <sub>CC</sub> = 4.75 V I <sub>OH</sub> = -32 mA				2			V	
	$I_{OH} = -15 \text{ mA}$				2.4	3.3			
Vo	$V_{CC} = 4.5 \text{ V}, \qquad I_{OL} = 32 \text{ mA}$		0.3	0.55				V	
VOL	$V_{CC} = 4.75 \text{ V}, \qquad I_{OL} = 64 \text{ mA}$					0.3	0.55	٧	
$V_{hys}$	All inputs		0.2			0.2		V	
1.	$V_{CC} = 5.5 \text{ V}, \qquad V_{IN} = V_{CC}$			5				μΑ	
lj .	$V_{CC} = 5.25 \text{ V}, \qquad V_{IN} = V_{CC}$						5	μΑ	
l	$V_{CC} = 5.5 \text{ V}, \qquad V_{IN} = 2.7 \text{ V}$			±1				μA	
IH	$V_{CC} = 5.25 \text{ V}, \qquad V_{IN} = 2.7 \text{ V}$						±1	μΑ	
IJĽ	$V_{CC} = 5.5 \text{ V}, \qquad V_{IN} = 0.5 \text{ V}$			±1				μA	
ΊL	$V_{CC} = 5.25 \text{ V}, \qquad V_{IN} = 0.5 \text{ V}$						±1	μΑ	
la at	$V_{CC} = 5.5 \text{ V}, \qquad V_{OUT} = 0 \text{ V}$	-60	-120	-225				mA	
I <sub>OS</sub> ‡	$V_{CC} = 5.25 \text{ V}, \qquad V_{OUT} = 0 \text{ V}$				-60	-120	-225	ША	
l <sub>off</sub>	$V_{CC} = 0 \text{ V}, \qquad V_{OUT} = 4.5 \text{ V}$			±1			±1	μΑ	
Icc	$V_{CC} = 5.5 \text{ V}, \qquad V_{IN} \le 0.2 \text{ V}, \qquad V_{IN} \ge V_{CC} - 0.2 \text{ V}$	/	0.1	0.2				mA	
100	$V_{CC} = 5.25 \text{ V}, \qquad V_{IN} \le 0.2 \text{ V}, \qquad V_{IN} \ge V_{CC} - 0.2 \text{ V}$	/				0.1	0.2	IIIA	
Aloo	$V_{CC} = 5.5 \text{ V}, V_{IN} = 3.4 \text{ V}$ , $f_1 = 0$ , Outputs open		0.5	2				mA	
ΔICC	$V_{CC} = 5.25 \text{ V}, V_{IN} = 3.4 \text{ V}$ f <sub>1</sub> = 0, Outputs open					0.5	2	IIIA	
. «Г	$V_{CC}$ = 5.5 V, Outputs open, One bit switching at 50% du cycle, $V_{IN} \le 0.2$ V or $V_{IN} \ge V_{CC} - 0.2$ V	ty	0.06	0.12				mA/	
<sup>I</sup> CCD <sup>¶</sup>	$V_{CC}$ = 5.25 V, Outputs open, One bit switching at 50% duty cycle, $V_{IN} \le 0.2 \text{ V or } V_{IN} \ge V_{CC} - 0.2 \text{ V}$					0.06	0.12	MHz	

<sup>†</sup> Typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .



<sup>‡</sup> Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample-and-hold techniques are preferable to minimize internal chip heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output can raise the chip temperature well above normal and cause invalid readings in other parametric tests. In any sequence of parameter tests, IOS tests should be performed last.

<sup>§</sup> Per TTL-driven input ( $V_{IN} = 3.4 \text{ V}$ ); all other inputs at  $V_{CC}$  or GND

This parameter is derived for use in total power-supply calculations.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted) (continued)

DADAMETER	TEST CONDITIONS				54FCT13	8T	CY	74FCT13	8T	LINUT
PARAMETER	R TEST CONDITIONS			MIN	TYP <sup>†</sup>	MAX	MIN	TYP <sup>†</sup>	MAX	UNIT
			$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$		0.7	1.4				
lc#	E <sub>3</sub>	at 50% duty cycle	V <sub>IN</sub> = 3.4 V or GND		1	2.4				mA
I.C.	$V_{CC} = 5.25 \text{ V},$ Outputs open, Switch $\overline{E}_1$ , $\overline{E}_2$ , or	One output switching at f <sub>1</sub> = 10 MHz	$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$					0.7	1.4	IIIA
	E <sub>3</sub>	at 50% duty cycle	V <sub>IN</sub> = 3.4 V or GND					1	2.4	
C <sub>i</sub>					5	10		5	10	pF
Co					9	12		9	12	pF

 $<sup>\</sup>overline{\dagger}$  Typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

Where:

IC = Total supply current

I<sub>CC</sub> = Power-supply current with CMOS input levels

 $\Delta I_{CC}$  = Power-supply current for a TTL high input ( $V_{IN} = 3.4 \text{ V}$ )

D<sub>H</sub> = Duty cycle for TTL inputs high N<sub>T</sub> = Number of TTL inputs at D<sub>H</sub>

I<sub>CCD</sub> = Dynamic current caused by an input transition pair (HLH or LHL)

= Clock frequency for registered devices, otherwise zero

f<sub>1</sub> = Input signal frequency

N<sub>1</sub> = Number of inputs changing at f<sub>1</sub>

All currents are in milliamperes and all frequencies are in megahertz.

Values for these conditions are examples of the ICC formula.

## switching characteristics over operating free-air temperature range (see Figure 1)

PARAMETER	FROM	то	CY54FC	T138T	CY54FC1	UNIT	
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	UNIT
<sup>t</sup> PLH	А	ō	1.5	12	1.5	6	ns
t <sub>PHL</sub>	A	U	1.5	12	1.5	6	115
<sup>t</sup> PLH	FF	ō	1.5	12.5	1.5	6.1	ne
t <sub>PHL</sub>	$\overline{E}_1$ or $\overline{E}_2$	U	1.5	12.5	1.5	6.1	ns
<sup>t</sup> PLH	Eo	ō	1.5	12.5	1.5	6.1	nc
<sup>t</sup> PHL	E3		1.5	12.5	1.5	6.1	ns

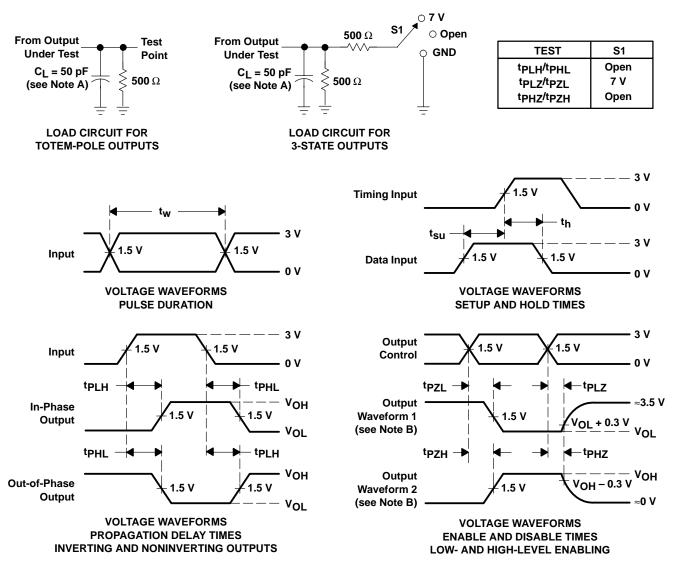
## switching characteristics over operating free-air temperature range (see Figure 1)

PARAMETER	FROM	TO (OUTPUT)	CY74F0	CY74FCT138T		CY74FCT138AT		CY74FCT138CT	
PARAMETER	(INPUT)		MIN	MAX	MIN	MAX	MIN	MAX	UNIT
<sup>t</sup> PLH	А	ō	1.5	9	1.5	5.8	1.5	5	no
<sup>t</sup> PHL		O	1.5	9	1.5	5.8	1.5	5	ns
<sup>t</sup> PLH	EE	ō	1.5	9	1.5	5.9	1.5	5	no
<sup>t</sup> PHL	$\overline{E}_1$ or $\overline{E}_2$	ľ	1.5	9	1.5	5.9	1.5	5	ns
<sup>t</sup> PLH	-	ō	1.5	9	1.5	5.9	1.5	5	no
<sup>t</sup> PHL	E3	U	1.5	9	1.5	5.9	1.5	5	ns



 $<sup>^{\#}</sup>$ IC = ICC +  $\triangle$ ICC  $\times$  DH  $\times$  NT + ICCD (f<sub>0</sub>/2 + f<sub>1</sub>  $\times$  N<sub>1</sub>)

#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms









#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
5962-9223302M2A	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
5962-9223302MEA	ACTIVE	CDIP	J	16	1	TBD	Call TI	N / A for Pkg Type
5962-9223306M2A	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
5962-9223306MEA	ACTIVE	CDIP	J	16	1	TBD	Call TI	N / A for Pkg Type
CY54FCT138CTLMB	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
CY54FCT138TDMB	ACTIVE	CDIP	J	16	1	TBD	Call TI	N / A for Pkg Type
CY54FCT138TLMB	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
CY74FCT138ATQCT	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT138ATQCTE4	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT138ATQCTG4	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT138ATSOC	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT138ATSOCE4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT138ATSOCT	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT138ATSOCTE4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT138CTQCT	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT138CTQCTE4	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT138CTQCTG4	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT138CTSOC	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT138CTSOCE4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT138CTSOCT	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT138CTSOCTE4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY74FCT138TQCT	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT138TQCTE4	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
CY74FCT138TQCTG4	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR

(1) The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.



#### PACKAGE OPTION ADDENDUM

7-Apr-2006

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <a href="http://www.ti.com/productcontent">http://www.ti.com/productcontent</a> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### **IMPORTANT NOTICE**

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products		Applications	
Amplifiers	amplifier.ti.com	Audio	www.ti.com/audio
Data Converters	dataconverter.ti.com	Automotive	www.ti.com/automotive
DSP	dsp.ti.com	Broadband	www.ti.com/broadband
Interface	interface.ti.com	Digital Control	www.ti.com/digitalcontrol
Logic	logic.ti.com	Military	www.ti.com/military
Power Mgmt	power.ti.com	Optical Networking	www.ti.com/opticalnetwork
Microcontrollers	microcontroller.ti.com	Security	www.ti.com/security
		Telephony	www.ti.com/telephony
		Video & Imaging	www.ti.com/video
		Wireless	www.ti.com/wireless

Mailing Address: Texas Instruments

Post Office Box 655303 Dallas, Texas 75265

Copyright © 2006, Texas Instruments Incorporated